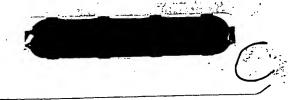


Subclass	SUE CLASSIFICATION
Class	SUE CLAS



PATENT NUMBER

III ITY Patent Application

U.S. UTILITY ALGERIA Application					
(£)	O.I.P.E.	7	PATENT DA	TI	
	1 1	, _~			
SCANNED_	A.D. JEAN	<u> </u>	Ì		

	at proper on temps come	AND COMPANY OF	*** ***		*** *** *		
1	APPLICATION NO.	CONT/PRIOR	CLASS	SUBCLASS	ART UNIT	EXAMINER	. 44
	09/629022	D	250 ·	310	2881	Fernander	Ţ,
	· ·	*			1994	EN BRIDE	

Douglas Do Jeff Johnson



Apparatus for measuring features of a semiconductor device

Best Available Copy ISSUING CLASSIFICATION CROSS REFERENCE(S) SUBCLASS (ONE SUBCLASS PER BLOCK) CLASS SUBCLASS

· 1000年1月1日 1000年1月 100		The second			
DISCONNET S	DRAWINGS			CLAIMS ALLOWED	
DISCLAIMER	Sheets Drwg.	Figs. Drwg.	Print Fig.	Total Claims Print Claim (cr.O.G.	
		يغر بير			
The term of this patent	3,4			NOTICE OF ALLOWANCE MAILED	
subsequent to the subsequent t	(Date)		(Date)		
nas been discialmed a	(Assistant C		(Oata)		
not extend beyond the expiration date				ISSUE FEE	
OIU.SIR IBIISTO			1	Amount Due Date Paid	
	(Primary B	xaminer)	(Date)		
The terminal months of			, 3	ISSUE BATCH NUMBER	
this patent have been disclaimed.	(Legal Instrume	ints Examiner)	(Date)		
WARNING:	tricted Unauthorized	disclosure may be	mobilited by the	United States Code Title 35, Sections 122, 181 and 368	

and the state of the control of the state of		
PTO 488A	FILED WITH: DISK (CI	RF) FICHE CO-RC